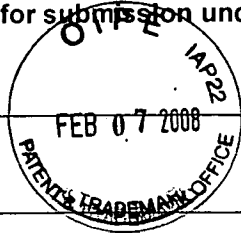


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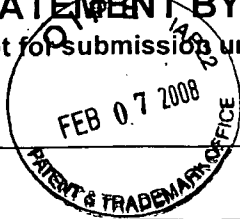


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Filing Date	2004-01-27
First Named Inventor	McCallister, Ronald D.
Art Unit	2611
Examiner Name	BAYARD, Emmanuel
Attorney Docket Number	2298-020

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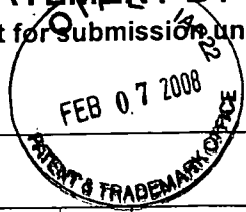
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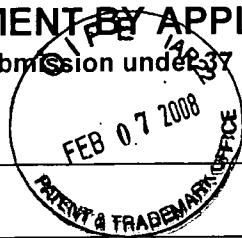
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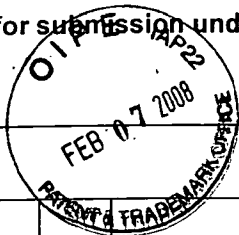
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